Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/660,467	USUI, TAKAHIRO
Examiner	Art Unit
Lamson D. Nguyen	2861

	SEAR	CHED	
Class	Subclass	Date	Examiner
347	54	e/6/06	Q
347	57	1/8/06	
347	56	2/6/06	\bigcirc
347	68	2/8/06	\bigcap
347	10	2/6/06	7^{\prime}
347	1/	16/06	7
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
347	57	26/06			
347	68	2/6/06			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Est Search	J.C/08			
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